

Features and Benefits

- 3.3 to 5 V logic supply range
- Power-on reset (POR)
- To 10 MHz data input rate
- CMOS, TTL compatible inputs
- -40°C operation available
- Low-power CMOS logic and latches
- Schmitt trigger inputs for improved noise immunity
- High-voltage current-sink outputs
- Internal pull-up/pull-down resistors
- Output transient-protection diodes
- Single or split supply operation

Packages:

Not to scale



18-pin DIP (Package A)



20-pin SOICW (package LW) (drop-in replacement for discontinued 18-pin SOIC variants)

Description

The merging of low-power CMOS logic and bipolar output power drivers using the proprietary DABiC-5 fabrication process permit the A6841 integrated circuits to be used in a wide variety of peripheral power driver applications. Each device has an eight-bit CMOS shift register and CMOS control circuitry, eight CMOS data latches, and eight bipolar current-sinking Darlington output drivers. The 500 mA, NPN Darlington outputs, with integral transient-suppression diodes, are suitable for use with relays, solenoids, and other inductive loads.

All package variations of the A6841 offer premium performance with a minimum output-breakdown voltage rating of $50 \, \text{V} (35 \, \text{V})$ sustaining). All drivers can be operated with a split supply where the negative supply is up to $-20 \, \text{V}$.

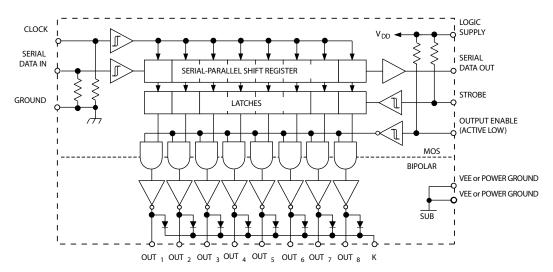
The CMOS inputs are compatible with standard CMOS logic levels. TTL circuits may require the use of appropriate pull-up resistors. By using the serial data output, drivers can be cascaded for interface applications requiring additional drive lines.

The A6841 is provided in an 18-pin plastic DIP (suffix A), and a 20-pin wide-body SOIC (suffix LW) with improved thermal characteristics compared to the 18-pin SOIC version it replaces (100% pin-compatible electrically). These devices are lead (Pb) free, with 100% matte tin plated leadframes.

Applications include:

- Relays
- Solenoids
- Inductive loads

Functional Block Diagram



Selection Guide

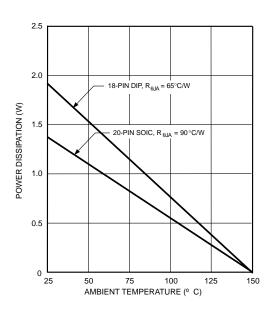
Part Number	Package	Packing	Ambient
A6841EA-T	18-pin DIP	21 pieces per tube	
A6841ELW-20-T	20-pin wide body SOIC	37 pieces per tube	–40°C to 85°C
A6841ELWTR-20-T	20-pin wide body SOIC	1000 pieces per reel	
A6841SA-T	18-pin DIP	21 pieces per tube	
A6841SLW-20-T	20-pin wide body SOIC	37 pieces per tube	–20°C to 85°C
A6841SLWTR-20-T	20-pin wide body SOIC	1000 pieces per reel	

Absolute Maximum Ratings*

Characteristic	Symbol	Notes	Rating	Units
Logic Supply Voltage	V _{DD}		7	V
Emitter Supply Voltage	V _{EE}		-20	V
Input Voltage Range	V _{IN}		-0.3 to V _{DD} +0.3	V
Outrout Valtage	V _{CE}		50	V
Output Voltage	V _{CE(SUS)}	For inductive load applications	35	V
Continuous Output Current	I _{OUT}	Each output	500	mA
On anating Ambient Temperature		Range E	-40 to 85	°C
Operating Ambient Temperature	T _A	Range S	-20 to 85	°C
Maximum Junction Temperature	T _J (max)		150	°C
Storage Temperature	T _{stg}		-55 to 150	°C

Caution: CMOS devices have input-static protection, but are susceptible to damage when exposed to extremely high static-electrical charges.

Allowable Package Power Dissipation, PD





ELECTRICAL CHARACTERISTICS¹ Unless otherwise noted: T_A = 25°C, V_{EE} = 0 V, logic supply operating voltage V_{DD} = 3.0 to 5.5 V

			V _{dd} = 3.3 V		V _{dd} = 5 V				
Characteristic	Symbol	Test Conditions	Min.	Тур.	Max.	Min.	Тур.	Max.	Units
Output Leakage Current	I _{CEX}	V _{OUT} = 50 V	-	_	10	_	_	10	μΑ
Output Sustaining Voltage	V _{CE(SUS)}	I _{OUT} = 350 mA, L = 3 mH	35	_	_	35	-	T -	V
2 11 2 2 11		I _{OUT} = 100 mA	_	_	1.1	-	_	1.1	V
Collector–Emitter Saturation Voltage	V _{CE(SAT)}	I _{OUT} = 200 mA	_	_	1.3	-	-	1.3	V
Voltage	' '	I _{OUT} = 350 mA	_	_	1.6	_	_	1.6	V
Input Voltage	V _{IN(1)}		2.2	_	-	3.3	-	-	V
Input voltage	V _{IN(0)}		_	_	1.1	-	_	1.7	V
Input Resistance	R _{IN}		50	_	_	50	-	-	kΩ
Serial Data Output Voltage	V _{OUT(1)}	I _{OUT} = -200 μA	2.8	3.05	_	4.5	4.75	T -	V
Seriai Data Output Voltage	V _{OUT(0)}	I _{OUT} = 200 μA	_	0.15	0.3	-	0.15	0.3	V
Maximum Clock Frequency ²	f _c		10	_	-	10	_	-	MHz
	I _{DD(1)}	One output on, OE = L, ST = H	-	_	2.0	-	-	2.0	mA
Logic Supply Current	I _{DD(0)}	All outputs off, OE = H, ST = H, P1 through P8 = L	_	_	100	_	_	100	μА
Clamp Diode Leakage Current	I _r	V _r = 50 V	_	_	50	-	-	50	μA
Clamp Diode Forward Voltage	V _f	I _f = 350 mA	_	_	2	_	_	2	V
Outside Frankla to Outside Delay	t _{dis(BQ)}	V _{CC} = 50 V, R1 = 500 Ω, C1≤30 pF	_	_	1.0	_	_	1.0	μs
Output Enable-to-Output Delay	t _{en(BQ)}	V _{CC} = 50 V, R1 = 500 Ω, C1≤30 pF	-	_	1.0	-	-	1.0	μs
Strobe-to-Output Delay	t _{p(STH-QL)}	V _{CC} = 50 V, R1 = 500 Ω, C1≤30 pF	-	_	1.0	-	_	1.0	μs
Strobe-to-Output Delay	t _{p(STH-QH)}	V _{CC} = 50 V, R1 = 500 Ω, C1≤30 pF	_	_	1.0	-	-	1.0	μs
Output Fall Time	t _f	V _{CC} = 50 V, R1 = 500 Ω, C1≤30 pF	-	_	1.0	-	-	1.0	μs
Output Rise Time	t _r	V _{CC} = 50 V, R1 = 500 Ω, C1≤30 pF	-	_	1.0	-	-	1.0	μs
Clock-to-Serial Data Out Delay	t _{p(CH-SQX)}	I _{OUT} = ±200 μA	_	50	_	-	50	-	ns

¹Positive (negative) current is defined as conventional current going into (coming out of) the specified device pin.

Truth Table

Serial		Shift Register Contents	Serial		Latch Contents	Output	Output Contents
Data	Clock		Data	Strobe		Enable	
Input	Input	l ₁ l ₂ l ₃ l ₈	Output	Input	l ₁ l ₂ l ₃ l ₈	Input	l ₁ l ₂ l ₃ l ₈
Н	Т	H R ₁ R ₂ R ₇	R ₇				
L	7	L R ₁ R ₂ R ₇	R ₇				
Х	l	$R_1 R_2 R_3 R_8$	R ₈				
		X X X X	Х	L	R ₁ R ₂ R ₃ R ₈		
		P ₁ P ₂ P ₃ P ₈	P ₈	Н	P ₁ P ₂ P ₃ P ₈	L	P ₁ P ₂ P ₃ P ₈
					X X X X	Н	ннн н

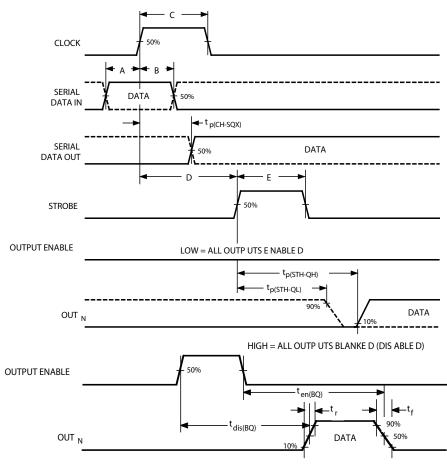
L = Low Logic Level H = High Logic Level P = Present State R = Previous State

X = Irrelevant



²Operation at a clock frequency greater than the specified minimum value is possible but not warranteed.

Timing Requirements and Specifications (Logic Levels are V_{DD} and Ground)



Key	Description	Symbol	Time (ns)
А	Data Active Time Before Clock Pulse (Data Set-Up Time)	t _{su(D)}	25
В	Data Active Time After Clock Pulse (Data Hold Time)	t _{h(D)}	25
С	Clock Pulse Width	t _{w(CH)}	50
D	Time Between Clock Activation and Strobe	t _{su(C)}	100
Е	Strobe Pulse Width	t _{w(STH)}	50

NOTE: Timing is representative of a 10 MHz clock. Higher speeds may be attainable; operation at high temperatures will reduce the specified maximum clock frequency.

Powering-on with the inputs in the low state ensures that the registers and latches power-on in the low state (POR).

Serial Data present at the input is transferred to the shift register on the logical 0 to logical 1 transition of the CLOCK input pulse. On succeeding CLOCK pulses, the registers shift data information towards the SERIAL DATA OUT-PUT. The serial data must appear at the input prior to the rising edge of the CLOCK input waveform.

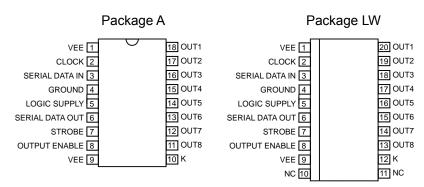
Information present at any register is transferred to the respective latch when the STROBE is high (serial-to-parallel conversion). The latches will continue to accept new data as long as the STROBE is held high. Applications where the latches are bypassed (STROBE tied high) will require that the OUTPUT ENABLE input be high during serial data entry.

When the OUTPUT ENABLE input is high, all of the output buffers are disabled (OFF). The information stored in the latches or shift register is not affected by the OUTPUT ENABLE input. With the OUTPUT ENABLE input low, the outputs are controlled by the state of their respective latches.



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Pin-out Diagrams



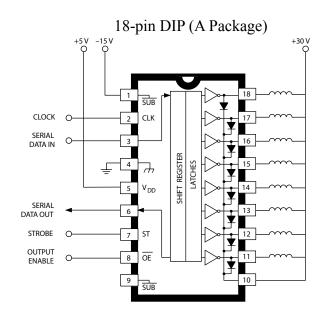
(NC pins, 10 and 11, not present on discontinued 18-pin LW package)

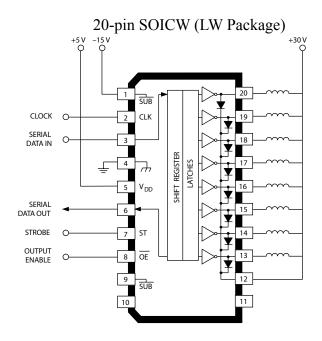
Terminal List Table

Name	Description	Number			
Name	Description	Package A	Package LW		
VEE	Power Ground to substrate	1, 9	1, 9		
CLOCK	Clock	2	2		
SERIAL DATA IN	Serial Data In	3	3		
GROUND	Logic Ground	4	4		
VDD	Logic Supply	5	5		
SERIAL DATA OUT	Serial Data Out, for cascading devices	6	6		
STROBE	Strobe	7	7		
OUTPUT ENABLE	Output Enable (active low)	8	8		
К	Common to +V _L , for inductive loads	10	12		
NC	Not internally connected	_	10, 11		
OUT8	Sink Output 8	11	13		
OUT7	Sink Output 7	12	14		
OUT6	Sink Output 6	13	15		
OUT5	Sink Output 5	14	16		
OUT4	Sink Output 4	15	17		
OUT3	Sink Output 3	16	18		
OUT2	Sink Output 2	17	19		
OUT1	Sink Output 1	18	20		



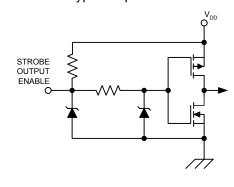
Typical Application Relay/solenoid driver using split supply

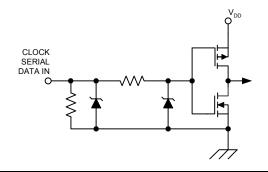




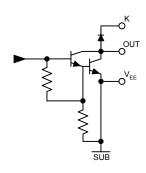
Pins 10 and 11 can float; other pins match discontinued 18-pin SOIC: 1 to 9 same, pins 12 to 20 match pins 10 to 18

Typical Input Circuits



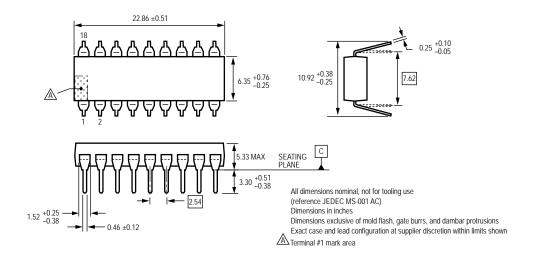


Typical Output Driver

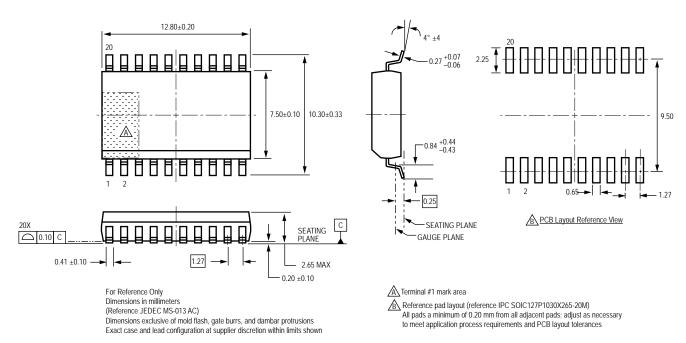




Package A, 18-Pin DIP



Package LW, 20-Pin SOICW





115 Northeast Cutoff

A6841

DABiC-5 8-Bit Serial Input Latched Sink Drivers

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